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Docket No.: SION-P12-041 (PATENT)

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Tre Patent Application of:

Miller et al.

Application No.: 10/734499

Confirmation No.: 1621

Filed: December 12, 2003

Art Unit: 2881

For:

METHOD AND APPARATUS FOR

ELECTROSPRAY AUGMENTED HIGH FIELD ASYMMETRIC ION MOBILITY

SPECTROMETRY

Examiner: Z. R. Hashmi

INFORMATION DISCLOSURE STATEMENT (IDS)

MS Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

Pursuant to 37 CFR 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached PTO/SB/08. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is filed before the mailing date of a first Office Action on the merits as far as is known to the undersigned (37 CFR 1.97(b)(3)).

A copy of each reference on the PTO/SB/08 is attached with the exception of the U.S. Patent references.

Application No.: 10/734499 Docket No.: SION-P12-041

In accordance with 37 CFR 1.97(g), the filing of this Information Disclosure Statement shall not be construed to mean that a search has been made or that no other material information as defined in 37 CFR 1.56(a) exists. In accordance with 37 CFR 1.97(h), the filing of this Information Disclosure statement shall not be construed to be an admission that any patent, publication or other information referred to therein is "prior art" for this invention unless specifically designated as such.

It is submitted that the Information Disclosure Statement is in compliance with 37 CFR 1.98 and the Examiner is respectfully requested to consider the listed references.

The Director is hereby authorized to charge any deficiency in the fees filed, asserted to be filed or which should have been filed herewith (or with any paper hereafter filed in this application by this firm) to our Deposit Account No. 18-1945, under Order No. SION-P12-041.

Dated: August 20, 2004

Respectfully submitted,

Agnes S. Lee

Registration No.: 46,862

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Application Number	10/734499				
Filing Date	December 12, 2003				
First Named Inventor	Raanan A. Miller				
Art Unit	2881				
Examiner Name	Hashmi, Zia R.				
Attorney Docket Number	SION-P12-041				

			U.S. PA	TENT DOCUMENTS	
Examiner Initials*	Cite No.1	Document Number Number-Kind Code ² (<i>if known</i>)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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000	State for form 1445/45/1			Application Number	10/734499
IN	IFORMATION	N DI	SCLOSURE	Filing Date	December 12, 2003
S	TATEMENT	BY /	APPLICANT	First Named Inventor	Raanan A. Miller
				Art Unit	2881
	(Use as many sh	eets as	s necessary)	Examiner Name	Hashmi, Zia R.
Sheet	2	of	4	Attorney Docket Number	SION-P12-041

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S	TATEMENT	BY A	APPLICANT	First Named Inventor	Raanan A. Miller
				Art Unit	2881
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Sheet	3	of	4	Attorney Docket Number	SION-P12-041

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Examiner Initials	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T²
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IN	NFORMATIO	N DI	SCLOSURE	Filing Date	December 12, 2003	
S	STATEMENT BY APPLICANT			First Named Inventor	Raanan A. Miller	
				Art Unit	2881	
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Sheet	4	of	4	Attorney Docket Number	SION-P12-041	

Examiner Initials	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
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^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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